


<b>Search Notes</b>  	<b>Application/Control No.</b>  10815106	<b>Applicant(s)/Patent Under Reexamination</b>  ICHIKAWA ET AL.
	<b>Examiner</b>  Chen, Shin-Hon	<b>Art Unit</b>  2131

SEARCHED			
Class	Subclass	Date	Examiner
713	158,168,169,170,156	6/8/07	S.C.

SEARCH NOTES		
Search Notes	Date	Examiner
USPAT, PGPUB, DERWENT, JPO, EPO (BRS search- see search history)	6/8/07	S.C.

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner